Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/043,896	LEE ET AL.	
Examiner	Art Unit	
George Y. Wang	2871	

SEARCHED			
Class	Subclass	Date	Examiner
385	27-32, 39, 43, 49, 50	12/26/2005	GW
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PG-Pub	Search	12/26/2005	GW
(see	printout)		

DATE	EXMR
12/26/2005	GW
12/20/2005	GW
12/26/2005	GW
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